

## SSC8L62GS3

#### **N-Channel Enhancement Mode MOSFET**

#### > Features

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	l <sub>D</sub>
60V	± 20\/	8mΩ@10V	63A
	±20V	12.5mΩ@4V5	03A

## > Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

#### 100% UIS + $\Delta VDS$ + Rg Tested!

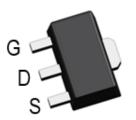
#### Applications

- Motor Drive Control
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

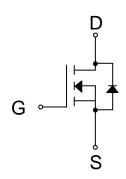
## > Ordering Information

Device	Package	Shipping
SSC8L62GS3	SOT-89-3L	1000/Reel

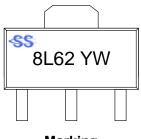
## > Pin Configuration



SOT-89-3L (Top View)



**Pin Configuration** 



**Marking** 

(YW: Internal Traceability Code)



#### Absolute Maximum Ratings (T<sub>A</sub>=25<sup>°</sup>C unless otherwise noted)

Symbol	Parameter	Ratings	Unit		
V <sub>DSS</sub>	Drain-to-Source Volta	Drain-to-Source Voltage		V	
V <sub>GSS</sub>	Gate-to-Source Volta	Gate-to-Source Voltage		V	
	0 11	T <sub>C</sub> =25℃	63	^	
l <sub>D</sub>	Continuous Drain Current <sup>d</sup>	T <sub>C</sub> =100℃	35	Α	
	Outine Dair Out 1	T <sub>A</sub> =25℃	19	^	
IDSM	Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =70°C	14	A	
Ірм	Pulsed Drain Current b		252	Α	
	5 5	Tc=25°C	52	34/	
$P_D$	Power Dissipation <sup>c</sup>	Tc=100℃	21	W	
Г	Power Dissipation <sup>a</sup>	T <sub>A</sub> =25℃	4.6	34/	
P <sub>DSM</sub>		T <sub>A</sub> =70°C	3	W	
las	Avalanche Current <sup>b</sup> L=0.5mH Single Pulse		18	Α	
Eas	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse		81	mJ	
TJ	Operation junction temperature		-55~150	%	
T <sub>STG</sub>	Storage temperature range		-55~150	$\mathbb{C}$	

### ➤ Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
RθJA	Junction-to-Ambient Thermal Resistance <sup>a</sup>	27	°C/W
R <sub>θJC</sub>	Junction-to-Case Thermal Resistance	2.4	C/ <b>VV</b>

#### Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.



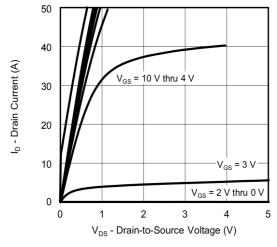


# $\succ$ Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

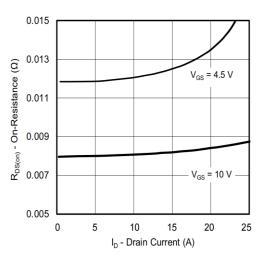
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250uA$	1	1.8	2.5	V
Drain Sauras On Basistanas	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10A		8	10.5	0
Drain-Source On-Resistance		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A		12.5	18	mΩ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V			1	μA
Gate-Source Leak Current	Igss	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V			±100	nA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 10A		30		s
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = 5A		0.8	1.3	V
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> = 0V, f = 1MHz		1.4		Ω
Input Capacitance	Ciss	V 00V V 0V		940		pF
Output Capacitance	Coss	$V_{DS} = 30V, V_{GS} = 0V,$		350		
Reverse Transfer Capacitance	Crss	f = 1MHz		24		
Total Gate Charge	Q <sub>G</sub>	101/1/		16		
Gate to Source Charge	Q <sub>G</sub> s	$V_{GS} = 10V, V_{DS} = 30V,$		4.4		nC
Gate to Drain Charge	Q <sub>GD</sub>	- I <sub>D</sub> = 10A		2.5		
Turn-on Delay Time	$T_{D(ON)}$			8		
Rise Time	Tr	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 30V,		4		]
Turn-off Delay Time	T <sub>D(OFF)</sub>	$R_L = 1.5\Omega$ , $R_G = 3\Omega$		18		ns
Fall Time	T <sub>f</sub>			4.1		
Diode Recovery Time	Trr	I <sub>F</sub> =20A, di/dt=100A/us		24		ns
Diode Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =20A, di/dt=100A/us		54		nC



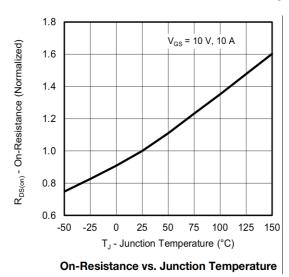
## > Typical Performance Characteristics (T<sub>A</sub>=25℃ unless otherwise noted)

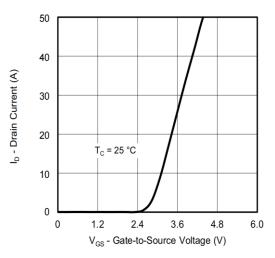


#### **Output Characteristics**

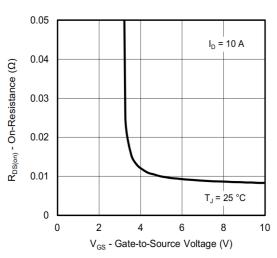


On-Resistance vs. Drain Current and Gate Voltage

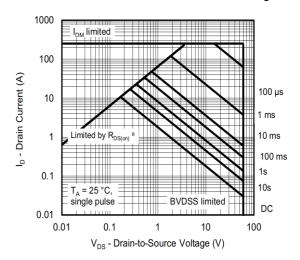




**Transfer Characteristics** 



On-Resistance vs. Gate-to-Source Voltage

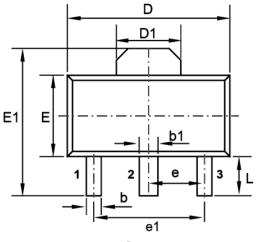


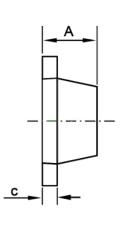
Safe Operating Area, Junction-to-Ambient



## Package Information

#### Mechanical Data

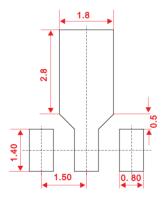




TOP VIEW SIDE VIEW

DIM	Millimeters			
	Min.	Тур.	Max.	
Α	1.40	-	1.60	
b	0.32	-	0.52	
b1	0.40	-	0.58	
С	0.35	-	0.44	
D	4.40	-	4.60	
D1	1.55 REF.			
E	2.30	-	2.60	
E1	3.94	-	4.25	
е		1.50		
e1		3.00		
L	0.90	-	1.20	

### Recommended Pad outline (Unit: mm)





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